Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/605,619	GARTNER, PERRY	
Examiner	Art Unit	
Randall Chin	1744	

SEARCHED					
Class	Subclass	Date	Examiner		
15	144.1				
15	144.2				
15	209.1	/			
15	210.1	V	V		
15	143.1	5/21/2005	pe		
UPDATED.	SCAPLUT	7/25/5	pe		
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INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARC)
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INVENTUR NAME SEAPLEH	5/21/05	re